

<b>Notice of References Cited</b>	Application/Control No. 10/634,350	Applicant(s)/Patent Under Reexamination SMITH ET AL.	
	Examiner Wesley D. Markham	Art Unit 1762	Page 1 of 1

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<p><b>Notice of References Cited</b></p>	<p>Application/Control No. 09/432,291</p>	<p>Applicant(s)/Patent Under Reexamination SMITH ET AL.</p>	
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